
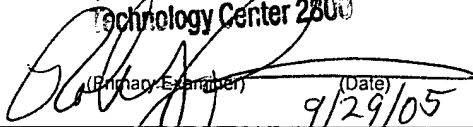



Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/052,113	LEE ET AL.	
	Examiner	Art Unit	
	Krista M. Flanagan	2631	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
375		354							
INTERNATIONAL CLASSIFICATION									
H	0	4	L	7/00					
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Krista Flanagan 2005.09.28 (Assistant Examiner) (Date)					Robert Pascal Supervisory Patent Examiner Technology Center 2800  (Primary Examiner) (Date) 9/29/05			Total Claims Allowed: 10	
 (Legal Instruments Examiner) (Date) 9/30/05								O.G. Print Claim(s)	O.G. Print Fig.
								1	3

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47							
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